

Search Notes

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Examiner

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Applicant(s)/Patent under
Reexamination

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Art Unit

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SEARCHED

Class	Subclass	Date	Examiner
714	15	10/11/2006	HN
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INTERFERENCE SEARCHED

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**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST Search updated (US-PGPUB; USPAT; USOCR; EPO; PO; DERWENT; IBM_TDB) (See search history printout report)	4/3/2007	HN